TOSHIBA Field Effect Transistor Silicon N-Channel MOS Type (U-MOSVI-H)

TPC8035-H

High Efficiency DC-DC Converter Applications Notebook PC Applications Portable Equipment Applications

- Small footprint due to small and thin package
- High-speed switching

www.Data

- Small gate charge: Qsw = 17 nC (typ.)
- Low drain-source ON-resistance: RDS (ON) = $2.3 \text{ m}\Omega$ (typ.)
- High forward transfer admittance: $|Y_{fs}| = 70 \text{ S (typ.)}$
- Low leakage current: $I_{DSS} = 10 \mu A \text{ (max) (V}_{DS} = 30 \text{ V)}$
- Enhancement mode: $V_{th} = 1.3 \text{ to } 2.3 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA)}$

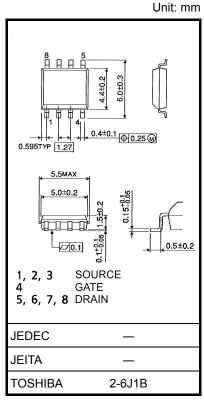
Absolute Maximum Ratings (Ta = 25°C)

Characte	eristic	Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	30	V	
Drain-gate voltage (F	$R_{GS} = 20 \text{ k}\Omega$)	V_{DGR}	30	٧	
Gate-source voltage		V_{GSS}	±20	٧	
Drain current	DC (Note 1)	ΙD	18	Α	
Drain current	Pulsed (Note 1)	I_{DP}	72		
Drain power dissipati	on $(t = 10 s)$ (Note 2a)	P_{D}	1.9	W	
Drain power dissipation (t = 1 (Note		P _D	1.0	W	
Single pulse avalanc	he energy (Note 3)	E _{AS}	211	mJ	
Avalanche current		I _{AR}	18	Α	
Repetitive avalanche	energy Note 2a) (Note 4)	E _{AR}	0.082	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature	range	T _{stg}	-55 to 150	°C	

Note: For Notes 1 to 4, refer to the next page.

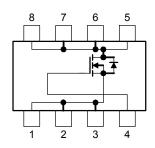
Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating" Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

This transistor is an electrostatic-sensitive device. Handle with care.



Weight: 0.085 g (typ.)

Circuit Configuration

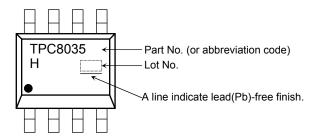




Thermal Characteristics

Characteristic	Symbol	Max	Unit	
Thermal resistance, channel to ambient (t = 10 s) (Note 2a)	R _{th (ch-a)}	65.8	°C/W	
Thermal resistance, channel to ambient $(t = 10 \text{ s})$ (Note 2b)	R _{th (ch-a)}	125	°C/W	

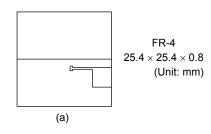
Marking (Note 5)

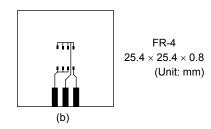


Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: (a) Device mounted on a glass-epoxy board (a)

(b) Device mounted on a glass-epoxy board (b)



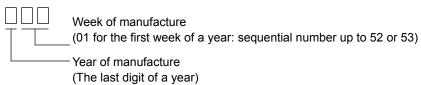


Note 3:
$$V_{DD}=24~V,~T_{ch}=25^{\circ}C$$
 (initial), $L=500~\mu H,~R_{G}=25~\Omega,~I_{AR}=18~A$

www.DataSNote 4:coRepetitive rating: pulse width limited by max channel temperature

Note 5: • on lower left of the marking indicates Pin 1.

* Weekly code: (Three digits)



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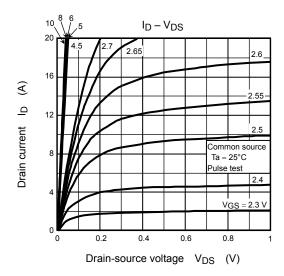


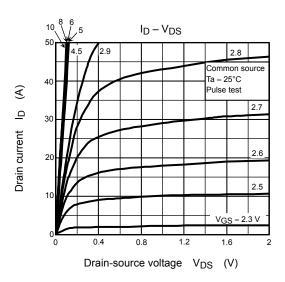
Electrical Characteristics (Ta = 25°C)

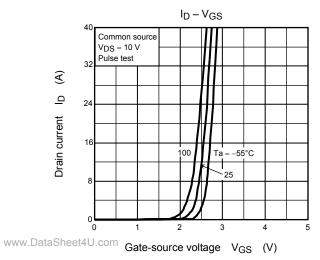
Characteristic		Symbol	Test Condition	Min	Тур.	Max	Unit	
Gate leakage cur	rent	I _{GSS}	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±100	nA	
Drain cut-OFF cu	rrent	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V		_	10	μА	
Drain-source breakdown voltage		V (BR) DSS	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	30	_	_	V	
Diam-source brea	akuowii voitage	V (BR) DSX	$I_D = 10 \text{ mA}, V_{GS} = -20 \text{ V}$	15	_	_	v	
Gate threshold vo	oltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	1.3	_	2.3	V	
Drain source ON	rosistanco	Pro (out)	V _{GS} = 4.5 V, I _D = 9 A	_	2.6	3.6	m0	
Drain-source ON-resistance Forward transfer admittance		R _{DS} (ON)	V _{GS} = 10 V, I _D = 9 A	_	2.3	3.2	mΩ	
Forward transfer	admittance	Y _{fs}	V _{DS} = 10 V, I _D = 9 A	35	70	_	S	
Input capacitance		C _{iss}		_	6000	7800		
Reverse transfer	capacitance	C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	380	610	pF	
Output capacitance		Coss	-		1100			
Gate resistance		rg	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	1.0	1.5	Ω	
Switching time	Rise time	t _r	ACS 0 A D O O O O O O O O O O O O O O O O O O	_	5.1	_	ns	
	Turn-ON time	t _{on}		_	16	_		
	Fall time	t _f		_	11	_		
	Turn-OFF time	t _{off}	V _{DD} ≈ 15 V Duty ≤ 1%, t _W = 10 μs	_	69	_		
Total gate charge		Qg	$V_{DD} \approx 24 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 18 \text{ A}$	_	82	_		
(gate-source plus	-source plus gate-drain)		$V_{DD} \approx 24 \text{ V}, V_{GS} = 5 \text{ V}, I_D = 18 \text{ A}$	_	44	_		
Gate-source charge 1		Q _{gs1}		_	14	_	nC	
Gate-drain ("miller") charge		Q _{gd}	$V_{DD} \approx 24 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 18 \text{ A}$	_	13	_		
Gate switch char	ge	Q _{SW}	1	_	17	_		

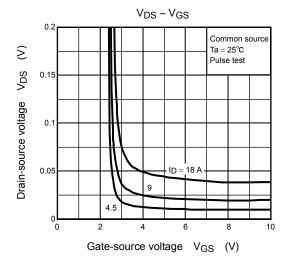
www.DaSource-Drain Ratings and Characteristics (Ta = 25°C)

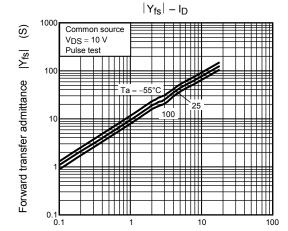
Characteri	stics		Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse	(Note 1)	I _{DRP}	_	_	_	72	Α
Forward voltage (diode)			V_{DSF}	I _{DR} = 18 A, V _{GS} = 0 V	_	_	-1.2	V



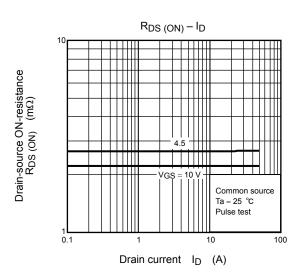




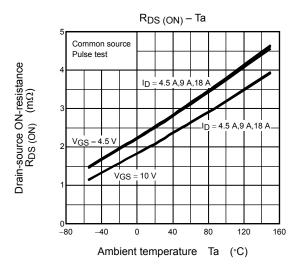


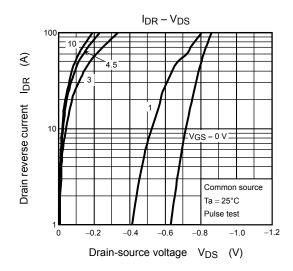


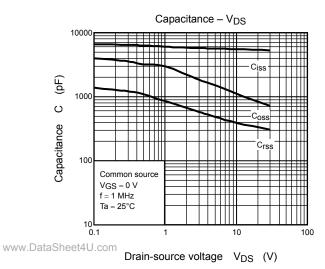
Drain current I_D (A)

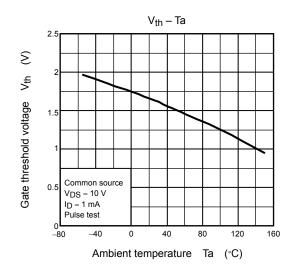


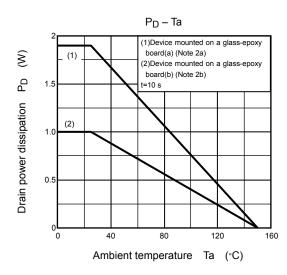
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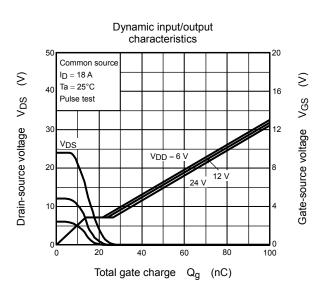


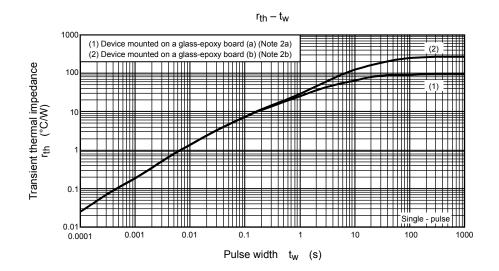


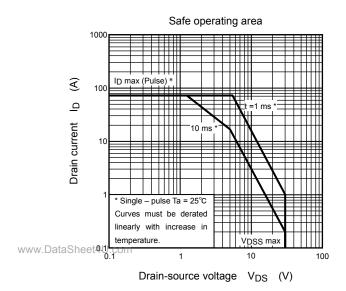












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